

**Issue Classification**

Application/Control No.

10761454

Applicant(s)/Patent Under Reexamination

FUJISAWA, EIZO

Examiner

Dabney, Phylesha L

Art Unit

2614

**ORIGINAL**

CLASS

SUBCLASS

379

433.13

**CROSS REFERENCE(S)**

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

379

433.11

455

575.4

**INTERNATIONAL CLASSIFICATION**

CLAIMED

NON-CLAIMED

H

0

4

M

1 / 00 (2006.01.01)

H

0

4

M

9 / 00 (2006.01.01)

Dabney, P L

12/10/07

(Assistant Examiner)

(Date)

Total Claims Allowed:

19

(Legal Instruments Examiner)

(Date)

CURTIS KUNTZ  
SUPERVISORY PATENT EXAMINER

TECHNOLOGY CENTER 2600

O.G. Print Claim(s)

7

O.G. Print Figure

1